Search Notes							

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/804,082	TANAKA ET AL.	
Examiner	Art Unit	
John I. Goodrow	1756	

SEARCHED				
Subclass	Date	Examiner		
108.4	9/12/2006	JG		
109.4				
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	108.4 109.4	Subclass Date 108.4 9/12/2006 109.4		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
430	108.4	9/12/06	JG		
	109.4				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
inventor name search and east	9/12/2006	JG	